

STN	<p>Elektrické zariadenia na meranie, riadenie a laboratórne použitie Požiadavky na elektromagnetickú kompatibilitu Časť 1: Všeobecné požiadavky</p>	<p>STN EN IEC 61326-1</p>
		35 6508

Electrical equipment for measurement, control and laboratory use - EMC requirements - Part 1: General requirements

Táto norma obsahuje anglickú verziu európskej normy.
This standard includes the English version of the European Standard.

Táto norma bola oznámená vo Vestníku ÚNMS SR č. 08/21

Obsahuje: EN IEC 61326-1:2021, IEC 61326-1:2020

Oznámením tejto normy sa od 04.06.2024 ruší
STN EN 61326-1 (35 6508) z októbra 2013

133302

EUROPEAN STANDARD
NORME EUROPÉENNE
EUROPÄISCHE NORM

EN IEC 61326-1

June 2021

ICS 25.040.40; 17.220.20; 33.100.20

Supersedes EN 61326-1:2013 and all of its amendments
and corrigenda (if any)

English Version

**Electrical equipment for measurement, control and laboratory
use - EMC requirements - Part 1: General requirements
(IEC 61326-1:2020)**

Matériel électrique de mesure, de commande et de
laboratoire - Exigences relatives à la CEM - Partie 1:
Exigences générales
(IEC 61326-1:2020)

Elektrische Mess-, Steuer-, Regel- und Laborgeräte - EMV-
Anforderungen - Teil 1: Allgemeine Anforderungen
(IEC 61326-1:2020)

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Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Rue de la Science 23, B-1040 Brussels

EN IEC 61326-1:2021 (E)**European foreword**

The text of document 65A/975/FDIS, future edition 3 of IEC 61326-1, prepared by SC 65A "System aspects" of IEC/TC 65 "Industrial-process measurement, control and automation" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 61326-1:2021.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2021-12-04
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2024-06-04

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In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60359	NOTE	Harmonized as EN 60359
IEC 61000-6-1:2016	NOTE	Harmonized as EN IEC 61000-6-1:2019 (not modified)
IEC 61000-6-2:2016	NOTE	Harmonized as EN IEC 61000-6-2:2019 (not modified)
IEC 61010 (series)	NOTE	Harmonized as EN IEC 61010 (series)
IEC 61326-2 (series)	NOTE	Harmonized as EN 61326-2 (series)

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 Where an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60050-161	1990	International Electrotechnical Vocabulary. Chapter 161: Electromagnetic compatibility	-	-
+ A1	1997		-	-
+ A2	1998		-	-
+ A3	2014		-	-
+ A4	2014		-	-
+ A5	2015		-	-
+ A6	2016		-	-
+ A7	2017		-	-
+ A8	2018		-	-
IEC 61000-3-2	2018	Electromagnetic compatibility (EMC) – Part 3-2: Limits – Limits for harmonic current emissions (equipment input current ≤ 16 A per phase)	EN IEC 61000-3-2	2019
IEC 61000-3-3	2013	Electromagnetic compatibility (EMC) - Part 3-3: Limits - Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤ 16 A per phase and not subject to conditional connection	EN 61000-3-3	2013
+ A1	2017		+ A1	2019
IEC 61000-3-11	2017	Electromagnetic compatibility (EMC) – Part 3-11: Limits – Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems – Equipment with rated current ≤ 75 A and subject to conditional connection	EN IEC 61000-3-11	2019

EN IEC 61326-1:2021 (E)

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 61000-3-12	2011	Electromagnetic compatibility (EMC) - Part 3-12: Limits - Limits for harmonic currents produced by equipment connected to public low-voltage systems with input current >16 A and ≤75 A per phase	EN 61000-3-12	2011
IEC 61000-4-2	2008	Electromagnetic compatibility (EMC) - Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test	EN 61000-4-2	2009
IEC 61000-4-3	2006	Electromagnetic compatibility (EMC) - Part 4-3 : Testing and measurement techniques - Radiated, radio-frequency, electromagnetic field immunity test	EN 61000-4-3	2006
+ A1	2007		+ A1	2008
+ A2	2010		+ A2	2010
IEC 61000-4-4	2012	Electromagnetic compatibility (EMC) - Part 4-4: Testing and measurement techniques - Electrical fast transient/burst immunity test	EN 61000-4-4	2012
IEC 61000-4-5	2014	Electromagnetic compatibility (EMC) - Part 4-5: Testing and measurement techniques - Surge immunity test	EN 61000-4-5	2014
+ A1	2017		+ A1	2017
IEC 61000-4-6	2013	Electromagnetic compatibility (EMC) - Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields	EN 61000-4-6	2014
IEC 61000-4-8	2009	Electromagnetic compatibility (EMC) - Part 4-8: Testing and measurement techniques - Power frequency magnetic field immunity test	EN 61000-4-8	2010
IEC 61000-4-11	2020	Electromagnetic compatibility (EMC) - Part 4-11: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests for equipment with input current up to 16 A per phase	EN IEC 61000-4-11	2020
CISPR 11 (mod)	2015	Industrial, scientific and medical equipment - Radio-frequency disturbance characteristics - Limits and methods of measurement	EN 55011	2016
+ A1	2016		+ A1	2017
-	-		+ A11	2020
+ A2	2019		+ A2	2021



IEC 61326-1

Edition 3.0 2020-10

INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Electrical equipment for measurement, control and laboratory use –
EMC requirements –
Part 1: General requirements**

**Matériel électrique de mesure, de commande et de laboratoire –
Exigences relatives à la CEM –
Partie 1: Exigences générales**





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INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Electrical equipment for measurement, control and laboratory use –
EMC requirements –
Part 1: General requirements**

**Matériel électrique de mesure, de commande et de laboratoire –
Exigences relatives à la CEM –
Partie 1: Exigences générales**

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CONTROL AND LABORATORY USE –
EMC REQUIREMENTS –****Part 1: General requirements****FOREWORD**

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International Standard IEC 61326-1 has been prepared by subcommittee 65A: System aspects, of IEC technical committee 65: Industrial-process measurement, control and automation.

This third edition cancels and replaces the second edition, published in 2012. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- the immunity test levels and performance criteria have been reviewed;
- requirements for portable test and measurement equipment have been clarified and amended;

- the description of the electromagnetic environments has been improved.

The text of this International Standard is based on the following documents:

FDIS	Report on voting
65A/975/FDIS	65A/985/RVD

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

In this document, the following print types are used:

- Terms used throughout this document which have been defined in Clause 3: SMALL CAPITALS

A list of all parts of the IEC 61326 series under the general title *Electrical equipment for measurement, control and laboratory use – EMC requirements*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

INTRODUCTION

Instruments and equipment within the scope of this document may often be geographically widespread and hence operate under a wide range of environmental conditions.

The limitation of undesired electromagnetic emissions ensures that no other equipment installed nearby is unduly influenced by the equipment under consideration. The limits are more or less specified by, and therefore taken from, IEC and International Special Committee on Radio Interference (CISPR) publications.

However, the equipment should function without undue degradation in an electromagnetic environment typical for the locations where it is intended to be operated. In this respect, the document specifies three different types of electromagnetic environment and the levels for immunity. More detailed information about issues related to electromagnetic environments are given in IEC TR 61000-2-5. Special risks, involving for example nearby or direct lightning strikes, circuit-breaking, or exceptionally high electromagnetic radiation in close proximity, are not covered.

Complex electric and/or electronic systems should require EMC planning in all phases of their design and installation, taking into consideration the electromagnetic environment, any special requirements, and the severity of failures.

This part of IEC 61326 specifies the EMC requirements that are generally applicable to all equipment within its scope. For certain types of equipment, these requirements will be supplemented or modified by the special requirements of one, or more than one, particular part IEC 61326-2 (all parts). These should be read in conjunction with the IEC 61326-1 requirements.

ELECTRICAL EQUIPMENT FOR MEASUREMENT, CONTROL AND LABORATORY USE – EMC REQUIREMENTS –

Part 1: General requirements

1 Scope

This part of IEC 61326 specifies requirements for immunity and emissions regarding electro-magnetic compatibility (EMC) for electrical equipment, operating from a supply or battery of less than 1 000 V AC or 1 500 V DC or from the circuit being measured. Equipment intended for professional, industrial-process, industrial-manufacturing and educational use is covered by this part. It includes equipment and computing devices for

- measurement and test;
- control;
- LABORATORY use;
- accessories intended for use with the above (such as sample handling equipment),

intended to be used in industrial and non-industrial locations.

Computing devices and assemblies and similar equipment within the scope of information technology equipment (ITE) and complying with applicable ITE EMC standards can be used in systems within the scope of this part of IEC 61326 without additional testing, if they are suitable for the intended electromagnetic environment.

It is generally considered that this product family standard takes precedence over the corresponding generic EMC standards.

The following equipment is covered by this document.

a) Electrical measurement and test equipment

This is equipment which, by electrical means, measures, indicates or records one or more electrical or non-electrical quantities, also non-measuring equipment such as signal generators, measurement standards, power supplies and transducers.

b) Electrical control equipment

This is equipment which controls one or more output quantities to specific values, with each value determined by manual settings, by local or remote programming, or by one or more input variables. This includes industrial process measurement and control (IPMC) equipment, which consists of devices such as:

- process controllers and regulators;
- programmable controllers;
- power supply units for equipment and systems (centralized or dedicated);
- analogue/digital indicators and recorders;
- process instrumentation;
- transducers, positioners, intelligent actuators, etc.

c) Electrical LABORATORY equipment, including In Vitro Diagnostic (IVD) medical equipment

This is equipment used to prepare or analyse materials, or measure, indicate or monitor physical quantities. This equipment might also be used in areas other than laboratories.

- d) Equipment a), b) or c) as above when being equipped with components having radio functionality, for example for wireless communication.

Equipment within the scope of this document might be operated in different electromagnetic environments; depending on the electromagnetic environment different emission and immunity test requirements are applicable.

This document considers three types of electromagnetic environments:

- BASIC ELECTROMAGNETIC ENVIRONMENT;
- INDUSTRIAL ELECTROMAGNETIC ENVIRONMENT;
- CONTROLLED ELECTROMAGNETIC ENVIRONMENT.

Corresponding immunity test requirements are described in Clause 6.

In terms of emission requirements, equipment shall be classified in Class A or Class B equipment, as per the requirements and procedure of CISPR 11. The corresponding emission requirements are described in Clause 7.

The specified emission and immunity requirements aim at achieving electromagnetic compatibility between equipment covered in this document and other equipment that might operate at locations with electromagnetic environments considered in this document. Guidance for an assessment concerning the risk for achieving EMC is given in Annex B.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050-161:1990, *International Electrotechnical Vocabulary (IEV) – Part 161: Electromagnetic compatibility*
 IEC 60050-161:1990/AMD1:1997
 IEC 60050-161:1990/AMD2:1998
 IEC 60050-161:1990/AMD3:2014
 IEC 60050-161:1990/AMD4:2014
 IEC 60050-161:1990/AMD5:2015
 IEC 60050-161:1990/AMD6:2016
 IEC 60050-161:1990/AMD7:2017
 IEC 60050-161:1990/AMD8:2018
 (available at <<http://www.electropedia.org>>)

IEC 61000-3-2:2018, *Electromagnetic compatibility (EMC) – Part 3-2: Limits – Limits for harmonic current emissions (equipment input current ≤16 A per phase)*

IEC 61000-3-3:2013, *Electromagnetic compatibility (EMC) – Part 3-3: Limits – Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤16 A per phase and not subject to conditional connection*
 IEC 61000-3-3:2013/AMD1:2017

IEC 61000-3-11:2017, *Electromagnetic compatibility (EMC) – Part 3-11: Limits – Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems – Equipment with rated current ≤75 A and subject to conditional connection*

IEC 61000-3-12:2011, *Electromagnetic compatibility (EMC) – Part 3-12: Limits – Limits for harmonic currents produced by equipment connected to public low-voltage systems with input current >16 A and ≤75 A per phase*

IEC 61000-4-2:2008, *Electromagnetic compatibility (EMC) – Part 4-2: Testing and measurement techniques – Electrostatic discharge immunity test*

IEC 61000-4-3:2006, *Electromagnetic compatibility (EMC) – Part 4-3: Testing and measurement techniques – Radiated, radio-frequency, electromagnetic field immunity test*

IEC 61000-4-3:2006/AMD1:2007

IEC 61000-4-3:2006/AMD2:2010

IEC 61000-4-4:2012, *Electromagnetic compatibility (EMC) – Part 4-4: Testing and measurement techniques – Electrical fast transient/burst immunity test*

IEC 61000-4-5:2014, *Electromagnetic compatibility (EMC) – Part 4-5: Testing and measurement techniques – Surge immunity test*

IEC 61000-4-5:2014/AMD1:2017

IEC 61000-4-6:2013, *Electromagnetic compatibility (EMC) – Part 4-6: Testing and measurement techniques – Immunity to conducted disturbances, induced by radio-frequency fields*

IEC 61000-4-8:2009, *Electromagnetic compatibility (EMC) – Part 4-8: Testing and measurement techniques – Power frequency magnetic field immunity test*

IEC 61000-4-11:2020, *Electromagnetic compatibility (EMC) – Part 4-11: Testing and measurement techniques – Voltage dips, short interruptions and voltage variations immunity tests for equipment with input current up to 16 A per phase*

CISPR 11:2015, *Industrial, scientific and medical equipment – Radio-frequency disturbance characteristics – Limits and methods of measurement*

CISPR 11:2015/AMD1:2016

CISPR 11:2015/AMD2:2019

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